Search Notes



pplication/Control No.	Applicant(s)/Patent under Reexamination

10/661,638 Examiner LOIS ZHENG

nation HIRAIWA ET AL.

Art Unit 1793

SEARCHED					
Class	Subclass	Date	Examiner		

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship search	8/14/2008	LLZ		
Updated EAST search	8/14/2008	LLZ		